

<b>Notice of References Cited</b>	Application/Control No. 10/658,378		Applicant(s)/Patent Under Reexamination NAKAYAMA ET AL.	
	Examiner Tuan Quach		Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,630,093	12-1986	Yamaguchi et al.	428/66.7
*	B	US-2003/0013240 A1	01-2003	Asano et al.	438/168
*	C	US-2004/0113236 A1	06-2004	Kurita et al.	257/620
*	D	US-2004/0242001 A1	12-2004	Toba et al.	438/690
*	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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